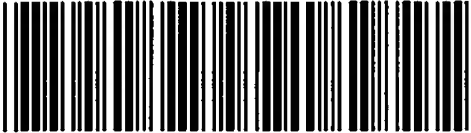


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10717607	KIM ET AL.
	Examiner	Art Unit
	Keefer, Michael E	2154

SEARCHED			
Class	Subclass	Date	Examiner
709	227 (updated 12/19/2007)	7/13/2007	MEK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	7/13/2007	MEK
Consulted Examiner Hassan Phillips	7/12/2007	MEK
Consulted Examiner Dustin Nguyen	7/12/2007	MEK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner